

**Search Notes****Application/Control No.**

10/766,478

**Examiner**

Hanh V. Tran

**Applicant(s)/Patent under Reexamination**

FITZ, HELMUT

**Art Unit**

3637

**SEARCHED**

Class	Subclass	Date	Examiner
312	348.4	12/27/2005	HVT
	348.1		
	348.2		
	265.5		
312	238	12/27/2005	HVT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search using various key words	12/27/2005	HVT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner